Search Notes



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Applicant(s)/Patent Under Reexamination

TAKAHATA ET AL.

Art Unit

Examiner

CHRISTIAN A HANNON

2618

SEARCHED					
Class	Subclass	Date	Examiner		
455	569.1	4/23/2008	CH		
181	171,172,157	4/23/2008	CH		
379	433.02	4/23/2008	CH		
381	388,386,333	4/23/2008	CH		

SEARCH NOTES				
Search Notes	Date	Examiner		
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INTERFERENCE SEARCH					
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